



PIC24FJ128GA010

PIC24FJ128GA010 Family Rev. A4 Silicon Errata

The PIC24FJ128GA010 family Rev. A4 parts you have received conform functionally to the Device Data Sheet (DS39747C), except for the anomalies described below. Any Data Sheet Clarification issues related to the PIC24FJ128GA010 Family will be reported in a separate Data Sheet errata. Please check the Microchip web site for any existing issues.

The following silicon errata apply only to PIC24FJ128GA010 devices with these Device/Revision IDs:

Part Number	Device ID	Revision ID
PIC24FJ128GA010	040Dh	07h
PIC24FJ96GA010	040Ch	07h
PIC24FJ64GA010	040Bh	07h
PIC24FJ128GA008	040Ah	07h
PIC24FJ96GA008	0409h	07h
PIC24FJ64GA008	0408h	07h
PIC24FJ128GA006	0407h	07h
PIC24FJ96GA006	0406h	07h
PIC24FJ64GA006	0405h	07h

The Device IDs (DEVID and DEVREV) are located at the last two implemented addresses in program memory. They are shown in hexadecimal in the format "DEVID DEVREV".

1. Module: Core

With Doze mode enabled, DOZEN (CLKDIV<11>) set, and the CPU Peripheral Clock Ratio Select bits (CLKDIV<14:12>) configured to any value except 0b000, writes to SFR locations can not be performed.

Work around

Disable Doze mode, or select 1:1 CPU peripheral clock ratio before modifying stated SFR locations, or avoid writing stated locations while Doze mode is enabled and CPU peripheral clock ratio other than 1:1 is selected. Configure the device prior to entering Doze mode and use the mode only to monitor applications activity.

Date Codes that pertain to this issue:

All engineering and production devices.

2. Module: JTAG

The current JTAG programming implementation is not compatible with third party programmers using SVF (Serial Vector Format) description language. JTAG boundary scan is supported by third party JTAG solutions and is not affected.

Work around

Program devices with In-Circuit Serial Programming™. JTAG programming can be accomplished using custom JTAG software. The current implementation may not be supported in future PIC24F revisions. JTAG boundary scan is supported.

Date Codes that pertain to this issue:

All engineering and production devices.

3. Module: PMP

In Master mode (MODE<1:0> = 11 or 10), back-to-back operations may cause the $\overline{\text{PMRD}}$ signal to not be generated. This limitation occurs when the peripheral is configured for zero Wait states (WAITM<3:0> = 0000).

Work around

The $\overline{\text{PMRD}}$ signal will be generated correctly if a minimum of one instruction cycle delay is inserted between the back-to-back operations. A NOP instruction, or any other instruction, is adequate. Selecting a delay other than zero will also permit the $\overline{\text{PMRD}}$ signal to be generated.

Date Codes that pertain to this issue:

All engineering and production devices.

4. Module: Interrupts

The device may not exit Doze mode if certain trap conditions occur. Address error, stack error and math error traps are affected. Oscillator failure and all interrupt sources are not affected and can cause the device to correctly exit Doze mode.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

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5. Module: Output Compare

The output compare module may output a single glitch for one T_{CY} after the module is enabled ($OCM<2:0> = 000$). This issue occurs when the output state of the associated Data Latch register ($LATx$) is in the opposite state of the Output Compare mode when the peripheral is enabled. It can also occur when switching between two Output Compare modes with opposite output states.

Work around

If the output glitch must be avoided, verify that the associated data latch value of the OCx pin matches the initial state of the desired Output Compare mode. For example, if Output Compare 5 is configured for mode, $OCM<2:0> = 001$, ensure that the $LATD<4>$ bit is clear prior to writing the OCM bits. The port latch output value will match the initial output state of the $OC5$ pin and avoid the glitch when the peripheral is enabled.

Date Codes that pertain to this issue:

All engineering and production devices.

6. Module: UART

The timing for transmitting a Sync Break has changed for this revision of silicon. The Sync Break is transmitted as soon as the $UTXBRK$ bit is set. A dummy write to $UxTXREG$ is still required and must be performed before the Sync Break has finished transmitting. Otherwise, the $UxTX$ may be held in the active state until the write has occurred.

Work around

Set the $UTXBRK$ bit when a Sync Break is required and perform a dummy $UxTXREG$ immediately following. This sequence will avoid holding the $UxTX$ pin in the active state.

Date Codes that pertain to this issue:

All engineering and production devices.

7. Module: UART

When the UART is in High-Speed mode, $BRGH$ ($UxMODE<3>$) is set, some optimal $UxBRG$ values can cause reception to fail.

Work around

Test $UxBRG$ values in the application to find a $UxBRG$ value that works consistently for more high-speed applications. User should verify that the $UxBRG$ baud rate error does not exceed the application limits.

Date Codes that pertain to this issue:

All engineering and production devices.

8. Module: UART

UART1 and UART2 hardware flow control options are not available for the 64-pin variants of the PIC24FJ128GA010 product family. As a result, the $UxCTS$ and $UxRTS$ pins not available and the $UEN<1:0>$ control bits are read as '0' (unimplemented). UART2 hardware flow control is not available for the 80-pin PIC24FJ128GA010 variants. Therefore associated pins and bits are not available for these devices.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

9. Module: UART

When the UART is in High-Speed mode ($BRGH = 1$), the auto-baud sequence can calculate the baud rate as if it were in Low-Speed mode.

Work around

The calculated baud rate can be modified by the following equation:

$$\text{New BRG Value} = (\text{Auto-Baud BRG} + 1) * 4 - 1$$

The user should verify baud rate error does not exceed application limits.

Date Codes that pertain to this issue:

All engineering and production devices.

10. Module: UART

With the auto-baud feature selected, the Sync Break character (0x55) may be loaded into the FIFO as data.

Work around

To prevent the Sync Break character from being loaded into the FIFO, load the $UxBRG$ register with either 0x0000 or 0xFFFF prior to enabling the auto-baud feature ($ABAUD = 1$).

Date Codes that pertain to this issue:

All engineering and production devices.

11. Module: A/D

Gain error may be as high as 5 LSbs for external references (VREF+ and VREF-) and 6 LSbs for internal reference (AVDD and AVSS).

Work around

Determine gain error from a known reference voltage and compensate the A/D result in software.

Date Codes that pertain to this issue:

All engineering and production devices.

12. Module: A/D

With the External Interrupt 0 (INT0) selected to start an A/D conversion (SSRC<2:0> = 001), the device may not wake-up from Sleep or Idle mode if more than one conversion is selected per interrupt (SMPI<3:0> <> 0000). Interrupts are generated correctly if the device is not in a Sleep or Idle mode.

Work around

Configure the A/D to generate an interrupt after every conversion (SMPI<3:0> = 0000). Use another wake-up source, such as the WDT or another interrupt source, to exit the Sleep or Idle mode. Alternatively, perform A/D conversions in Run mode.

Date Codes that pertain to this issue:

All engineering and production devices.

13. Module: SPI

The Enhanced SPI modes, selected by setting the Enhanced Buffer Enable bit, SPIBEN (SPIxCON2<0>), are not available.

Work around

Use Standard SPI mode by clearing the SPI Enhanced Buffer Enable bit, SPIBEN.

Date Codes that pertain to this issue:

All engineering and production devices.

14. Module: SPI

Master mode receptions using the SPI1 and SPI2 modules may not function correctly for bit rates above 8 Mbps if the master has the SMP bit (SPIxCON1<9>) cleared (master samples data at the middle of the serial clock period).

In this case, the data transmitted by the slave is received, shifted right by one bit, by the master. For example, if the data transmitted by the slave was 0xAAAA, the data received by the master would be 0x5555 (0xAAAA shifted right by one bit).

Work around

Users may set up the SPI module so that the bit rate is 8 Mbps or lower.

Alternatively, the bit rate can be configured higher than 8 Mbps, but the SMP bit (SPIxCON1<9>) of the SPI master must be set (master samples data at the end of the serial clock period).

Date Codes that pertain to this issue:

All engineering and production devices.

15. Module: SPI

A frame synchronization pulse may not be output in SPI Master mode if the pulse is selected to coincide with the first bit clock (SPIFE = 1). SCKx and SDOx waveforms are not affected.

Work around

Select the frame synchronization pulses to proceed the first bit clock (SPIFE = 0). The frame pulses will output correctly as described in the product data sheet.

Date Codes that pertain to this issue:

All engineering and production devices.

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16. Module: SPI

In SPI Slave mode (MSTEN = 0), with the slave select option enabled (SSEN = 1), the peripheral may accept transfers regardless of the \overline{SSx} pin state. The received data in SSPxBUF will be accurate but not intended for the device.

Work around

If the Slave select option is required (e.g., device one of multiple SPI slave nodes on an SPI network), two potential work arounds exist:

1. Configure the port associated with \overline{SSx} to an input and periodically read the PORT register. If the pin is read '0', disable the SPI peripheral (SPIEN = 0). Enable the peripheral (SPIEN = 1) if the pin is read as a logic '1'.
2. Read the pin associated with \overline{SSx} after a transfer is complete, indicated by the SPIxF bit being set. If the port pin is read as a digital '1', read SSPxBUF and discard the contents.

Date Codes that pertain to this issue:

All engineering and production devices.

17. Module: Oscillator

The Two-Speed Start-up feature may not be available on exit from Sleep mode with the IESO (Internal/External Switchover mode) enabled. Upon wake-up, the device will wait for the clock source used prior to entering Sleep mode to become ready.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

18. Module: Core

The CLKDIV register Reset value is incorrect. The register will reset with unimplemented bits equal to '1' for all Resets.

Work around

Mask out unimplemented bits to maintain software compatibility with future device revisions.

Date Codes that pertain to this issue:

All engineering and production devices.

19. Module: Core

If a clock failure occurs when the device is in Idle mode, the oscillator failure trap does not vector to the Trap Service Routine. Instead, the device will simply wake-up from Idle mode and continue code execution if the Fail-Safe Clock Monitor (FSCM) is enabled.

Work around

Whenever the device wakes up from Idle (assuming the FSCM is enabled), the user software should check the status of the OSCFAIL bit (INTCON1<1>) to determine whether a clock failure occurred and then perform an appropriate clock switch operation.

Date Codes that pertain to this issue:

All engineering and production devices.

20. Module: Core

On a Brown-out Reset, both the BOR and POR bits may be set. This may cause the Brown-out Reset condition to be indistinguishable from the Power-on Reset.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

21. Module: Ports

RC15 may output a digital '0' after a Reset until the Configuration Word settings are processed. The duration of time for this effect is TRST which is nominally 20 μ s.

After the Configuration Word is processed, RC15 is put into its reset state as a digital input.

Work around

Connect components not adversely affected by a digital 0 signal to RC15.

Date Codes that pertain to this issue:

All engineering and production devices.

22. Module: I²C™

During I²C Slave mode transactions, the Data/Address bit, $\overline{D/A}$, may not update during the data frame. This affects both 7 and 10-Bit Addressing modes.

I²C slave receptions are not affected by this issue.

Work around

Use the Read/Write bit, $\overline{R/W}$, and the Transmit Buffer Full Status Bit, TBF, to determine whether address or data information is being received.

For more information, see Figure 24-30 and Figure 24-31 in “**Section 24. Inter-Integrated Circuit™ (I²C™)**” (DS39702A).

Date Codes that pertain to this issue:

All engineering and production devices.

23. Module: I²C

When the I²C module is operating in Slave mode, after the ACKSTAT bit is set when receiving a NACK from the master, it may be cleared by the reception of a Start or Stop bit.

Work around

Store the value of the ACKSTAT bit immediately after receiving a NACK from the master.

Date Codes that pertain to this issue:

All engineering and production devices.

24. Module: UART

When an auto-baud is detected, the receive interrupt may occur twice. The first interrupt occurs at the beginning of the Start bit and the second after reception of the Sync field character.

Work around

If a receive interrupt occurs, check the URXDA bit ($UxSTA<0>$) to ensure that valid data is available. On the first interrupt, no data will be present. The second interrupt will have the Sync field character (55h) in the receive FIFO.

Date Codes that pertain to this issue:

All engineering and production devices.

25. Module: UART

The auto-baud may miscalculate for certain baud rates and clock speed combinations, resulting in a BRG value that is 1 greater or less than the expected value. When $UxBRG$ is less than 50, this can result in transmission and reception failures due to introducing error greater than 1%.

Work around

Test auto-baud calculations at various clock speed and baud rate combinations that would be used in applications. If an inaccurate $UxBRG$ value is generated, manually correct the baud rate in user code.

Date Codes that pertain to this issue:

All engineering and production devices.

26. Module: UART

When the UART is in 4x mode ($BRGH = 1$) and using two Stop bits ($STSEL = 1$), it may sample the first Stop bit instead of the second one.

This issue does not affect the other UART configurations.

Work around

Use the 16x baud rate option ($BRGH = 0$) and adjust the baud rate accordingly.

Date Codes that pertain to this issue:

All engineering and production devices.

27. Module: SPI

In SPI Master mode, the Disable SCKx pin bit, $DISSCK$, may not disable the SPI clock. As a result, the PIC® microcontroller must provide the SPI clock in Master mode.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

28. Module: Output Compare

In PWM mode, the output compare module may miss a compare event when the current duty cycle register (OCxRS) value is 0x0000 (0% duty cycle) and the OCxRS register is updated with a value of 0x0001. The compare event is only missed the first time a value of 0x0001 is written to OCxRS and the PWM output remains low for one PWM period. Subsequent PWM high and low times occur as expected.

Work around

If the current OCxRS register value is 0x0000, avoid writing a value of 0x0001 to OCxRS. Instead, write a value of 0x0002. In this case, however, the duty cycle will be slightly different from the desired value.

Date Codes that pertain to this issue:

All engineering and production devices.

29. Module: RTCC

The RTCC alarm repeat will generate an incorrect number of pin toggles. If the repeat count (x) is even, it will toggle the alarm pin 'x' times. If the repeat count is odd, one less than x toggles will be observed (x - 1).

Work around

None at this time.

Date Codes that pertain to this issue:

All engineering and production devices.

30. Module: RTCC

When performing writes to the ALCFGRPT register, some bits may become corrupted. The error occurs because of desynchronization between the CPU clock domain and the RTCC clock domain. The error causes data from the instruction *following* the ALCFGRPT instruction to overwrite the data in ALCFGRPT.

Work around

Always follow writes to the ALCFGRPT register with an additional write of the same data to a dummy location. These writes can be performed to RAM locations, W registers or unimplemented SFR space.

The optimal way to perform the work around:

1. Read ALCFGRPT into a RAM location.
2. Modify the ALCFGRPT data, as required, in RAM.
3. Move the RAM value into ALCFGRPT and a dummy location in back-to-back instructions.

Date Codes that pertain to this issue:

All engineering and production devices.

31. Module: CRC

If a CRC FIFO overflow occurs, the VWORD indicator will reset to '1' instead of '0'. Further writes to the FIFO will cause the VWORD indicator to reset to '0' after seven writes are performed.

Work around

Poll the CRCFUL bit (CRCCON<7>) to ensure that no writes are performed on the FIFO when it is full.

Date Codes that pertain to this issue:

All engineering and production devices.

32. Module: I/O Pins

The I/O pin output, VOL, meets the specifications in Table 1 below:

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

TABLE 1: DC CHARACTERISTICS: I/O PIN OUTPUT SPECIFICATIONS

DC CHARACTERISTICS			Standard Operating Conditions: 2.0V to 3.6V (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \leq T_A \leq +85^{\circ}\text{C}$ for Industrial				
Param No.	Sym	Characteristic	Min	Typ ⁽¹⁾	Max	Units	Conditions
DO10	VOL	Output Low Voltage All I/O Pins	—	—	.55	V	IOL = 8.5 mA, VDD = 3.6V
			—	—	.4	V	IOL = 7.8 mA, VDD = 3.6V
			—	—	.55	V	IOL = 6.0 mA, VDD = 2.0V
			—	—	.4	V	IOL = 5.0 mA, VDD = 2.0V

Note 1: Data in "Typ" column is at 3.3V, 25°C unless otherwise stated. Parameters are for design guidance only and are not tested.

33. Module: Core (Instruction Set)

If an instruction producing a read-after-write stall condition is executed inside a REPEAT loop, the instruction will be executed fewer times than was intended. For example, this loop:

```
repeat #0xf
inc [w1],[++w1]
```

will execute less than 15 times.

Work around

Avoid using REPEAT to repetitively execute instructions that create a stall condition. Instead, use a software loop using conditional branches.

Date Codes that pertain to this issue:

All engineering and production devices.

34. Module: Memory (Program Space Visibility)

When accessing data in the PSV area of data RAM, it is possible to generate a false address error trap condition by reading data located precisely at the lower address boundary (8000h). If data is read using an instruction with an auto-decrement, the resulting RAM address will be below the PSV boundary (i.e., at 7FFEh); this will result in an address error trap.

This false address error can also occur if a 32-bit MOV instruction is used to read the data at location 8000h.

Work around

Do not use the first location of the a PSV page (address 8000h).

Date Codes that pertain to this issue:

All engineering and production devices.

35. Module: I/O (PORTB)

When RB5 is configured as an open-drain output, it remains in a high-impedance state. The settings of LATB5 and TRISB5 have no effect on the pin's state.

Work around

If open-drain operation is not required, configure RB5 as a regular I/O (ODCB<5> = 0).

If open-drain operation is required, there are two options:

- select a different I/O pin for the open-drain function; or
- place an external transistor on the pin, and configure the pin as a regular I/O.

Date Codes that pertain to this issue:

All engineering and production devices.

36. Module: RTCC

Under certain circumstances, the value of the Alarm Repeat Counter (ALCFGRPT<7:0>) may be unexpectedly decremented. This happens only when a byte write to the upper byte of ALCFGRPT is performed in the interval between a device POR/BOR and the first edge from the RTCC clock source.

Work around

Do not perform byte writes on ALCFGRPT, particularly the upper byte.

Alternatively, wait until one period of the SOSC has completed before performing byte writes to ALCFGRPT.

Date Codes that pertain to this issue:

All engineering and production devices.

37. Module: UART (UERIF Interrupt)

The UART error interrupt may not occur, or occur at an incorrect time, if multiple errors occur during a short period of time.

Work around

Read the error flags in the UxSTA register whenever a byte is received to verify the error status. In most cases, these bits will be correct, even if the UART error interrupt fails to occur. For possible exceptions, refer to Errata # 38.

Date Codes that pertain to this issue:

All engineering and production devices.

38. Module: UART (FIFO Error Flags)

Under certain circumstances, the PERR and FERR error bits may not be correct for all bytes in the receive FIFO. This has only been observed when both of the following conditions are met:

- the UART receive interrupt is set to occur when the FIFO is full or $\frac{3}{4}$ full (UxSTA<7:6> = 1x); and
- more than 2 bytes with an error are received.

In these cases, only the first two bytes with a parity or framing error will have the corresponding bits indicate correctly. The error bits will not be set after this.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

39. Module: UART

The UART may not transmit if data is written before to TXxREG before the module is enabled.

Work around

To ensure transmission occurs, always enable the UART before the buffer is loaded. Use the procedure in **Section 16.2 “Transmitting in 8-Bit Data Mode”** or **Section 16.3 “Transmitting in 9-Bit Data Mode”** of the device data sheet (DS39747).

40. Module: I²C (Master Mode)

Under certain circumstances, a module operating in Master mode may Acknowledge its own command addressed to a slave device. This happens when the following occurs:

- 10-Bit Addressing mode is used (A10M = 1); and
- the I²C master has the same two upper address bits (I2CADD<9:8>) as the addressed slave module.

In these cases, the master also Acknowledges the address command and generates an erroneous I²C slave interrupt, as well as the I²C master interrupt.

Work around

Several options are available:

- When using 10-Bit Addressing mode, make certain that the master and slave devices do not share the same 2 MSBs of their addresses.

If this cannot be avoided:

- Clear the A10M bit (I2CxCON<10> = 0) prior to performing a Master mode transmit.
- Read the ADD10 bit (I2CxSTAT<8>) to check for a full 10-bit match whenever a slave I²C interrupt occurs on the master module.

Date Codes that pertain to this issue:

All engineering and production devices.

41. Module: I²C (Slave Mode)

Under certain circumstances, a module operating in Slave mode may not respond correctly to some of the special addresses reserved by the I²C protocol. This happens when the following occurs:

- 10-Bit Addressing mode is used (A10M = 1); and
- bits, A7:A1, of the slave address (I2CADD<7:1>) fall into the range of the reserved 7-bit address ranges '1111xxx' or '0000xxx'.

In these cases, the slave module Acknowledges the command and triggers an I²C slave interrupt; it does *not* copy the data into the I2CxRCV register or set the RBF bit.

Work around

Do not set bits, A7:A1, of the module's slave address equal to '1111xxx' or '0000xxx'.

Date Codes that pertain to this issue:

All engineering and production devices.

42. Module: I²C

Bit and byte-based operations may not have the intended affect on the I2CxSTAT register. It is possible for bit and byte operations performed on the lower byte of I2CxSTAT to clear the BCL bit (I2CxSTAT<10>). Bit and byte operation performed on the upper byte of I2CxSTAT, or on the BCL bit directly, may not be able to clear the BCL bit.

Work around

Modifications to the I2CxSTAT register should be done using word writes only. This can be done in C by always writing to the register itself and not the individual bits. For example, the code

```
I2C1STAT &= 0xFBFF
```

forces the compiler to use a word-based operation to clear the BCL bit. In assembly, it is done by not using BSET or BCLR instructions or instructions with the .b modifier.

Date Codes that pertain to this issue:

All engineering and production devices.

43. Module: I²C

The Transmit Buffer Full (TBF) flag (I2CxSTAT<0>) may not be cleared by hardware if a collision on the I²C bus occurs before the first falling clock edge during a transmission.

Work around

None.

Date Codes that pertain to this issue:

All engineering and production devices.

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44. Module: SPI (Master Mode)

In Master mode, the SPI Interrupt Flag (SPIxIF) and the SPIRBF bit (SPIxSTAT<0>) may both become set one-half clock cycle early, instead of on the clock edge. This occurs only under the following circumstances:

- Enhanced Buffer mode is disabled (SPIBEN = 0); and
- the module is configured for serial data output changes on transition from clock active to clock Idle state (CKE = 1)

If the application is using the interrupt flag to determine when data to be transmitted is written to the transmit buffer, the data currently in the buffer may be overwritten.

Work around

Before writing to the SPI buffer, check the SCKx pin to determine if the last clock edge has passed. Example 1 (below) demonstrates a method for doing this. In this example, the RD1 pin functions as the SPI clock, SCK, which is configured as Idle low.

Date Codes that pertain to this issue:

All engineering and production devices.

EXAMPLE 1: CHECKING THE STATE OF SPIxIF AGAINST THE SPI CLOCK

```
while(IFS0bits.SPI1IF == 0){} //wait for the transmission to complete
while(PORTDbits.RD1 == 1){} //wait for the last clock to finish
SPI1BUF = 0xFF; //write new data to the buffer
```

REVISION HISTORY

Rev A Document (9/2007)

Initial release of this document. Includes silicon issues 1 (Core), 2 (JTAG), 3 (PMP), 4 (Interrupts), 5 (Output Compare), 6-10 (UART), 11-12 (A/D), 13-16 (SPI), 17 (Oscillator), 18-20 (Core), 21 (Ports), 22-23 (I²C™), 24-26 (UART), 27 (SPI), 28 (Output Compare), 29-30 (RTCC), 31 (CRC) and 32 (I/O Pins).

Rev B Document (8/2008)

Added silicon issues 33 (Core – Instruction Set), 34 (Memory – Program Space Visibility), 35 (I/O – PORTB), 36 (RTCC), 37 (UART – UERIF Interrupt), 38 (UART – FIFO Error Flags), 39 (UART), 40 (I²C – Master Mode), 41 (I²C – Slave Mode), 42-43 (I²C) and 44 (SPI – Master Mode).

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NOTES:

Note the following details of the code protection feature on Microchip devices:

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- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
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Microchip received ISO/TS-16949:2002 certification for its worldwide headquarters, design and wafer fabrication facilities in Chandler and Tempe, Arizona; Gresham, Oregon and design centers in California and India. The Company's quality system processes and procedures are for its PIC® MCUs and dsPIC® DSCs, KEELOQ® code hopping devices, Serial EEPROMs, microperipherals, nonvolatile memory and analog products. In addition, Microchip's quality system for the design and manufacture of development systems is ISO 9001:2000 certified.



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